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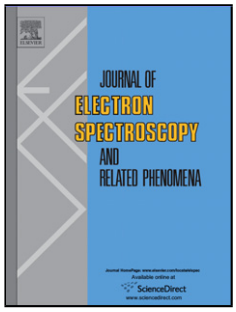

Title: Analytical and numerical methods for computing electron partial intensities in the case of multilayer systems

Author: Victor P. Afanas'ev Dmitry S. Efremenko Pavel S. Kaplya

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Highlights

- The OKG-model is extended to finite thickness layers
- An efficient matrix technique for computing partial intensities is proposed.
- Good agreement is obtained for computed partial intensities and experimental data.

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